



# Capture Latch Assembly for the NASA Docking System



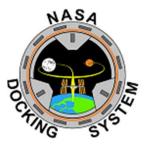
Brandon N. Dick – The Boeing Company Nathan Mauch – The Boeing Company Timothy Rupp – NASA Johnson Space Center

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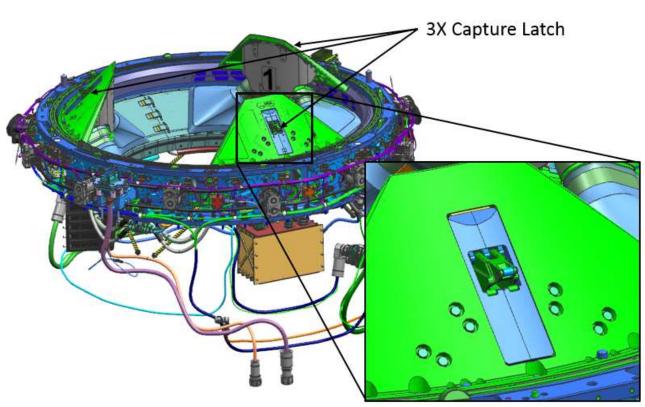


- Introduction
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- Capture Latch Operations
- Testing Summary
- Motor Failures
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- Lessons Learned

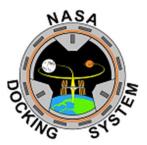
### Introduction



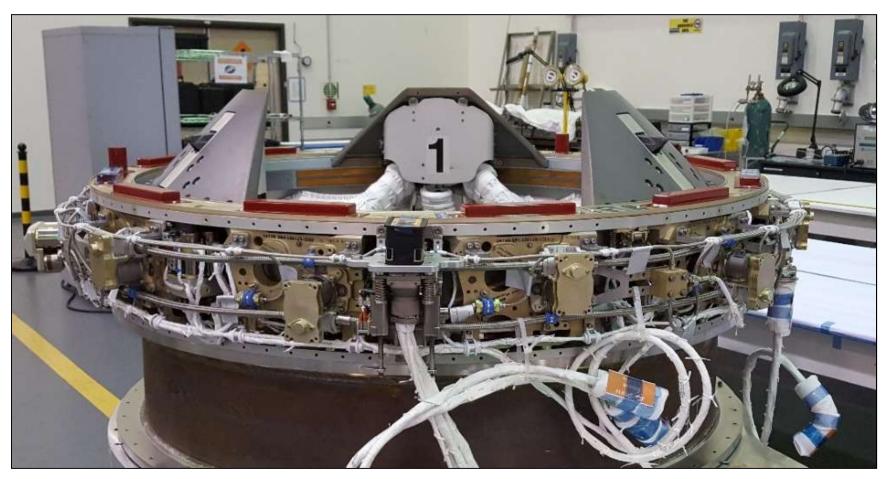
- Capture Latch Assembly
  - Part of the NDSB1
  - Connects the docking vehicles during Soft Capture.
  - Releases during Hard Capture
  - Three latches per NDSB1



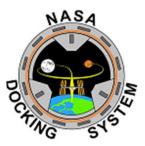
#### Introduction



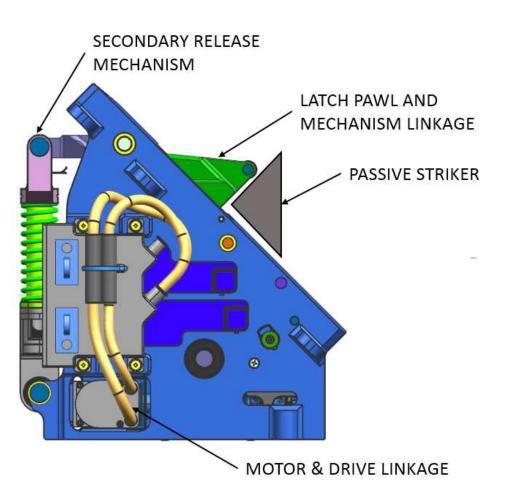
#### Capture Latches on first Flight NDSB1



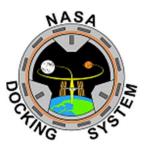
### **Design Overview**

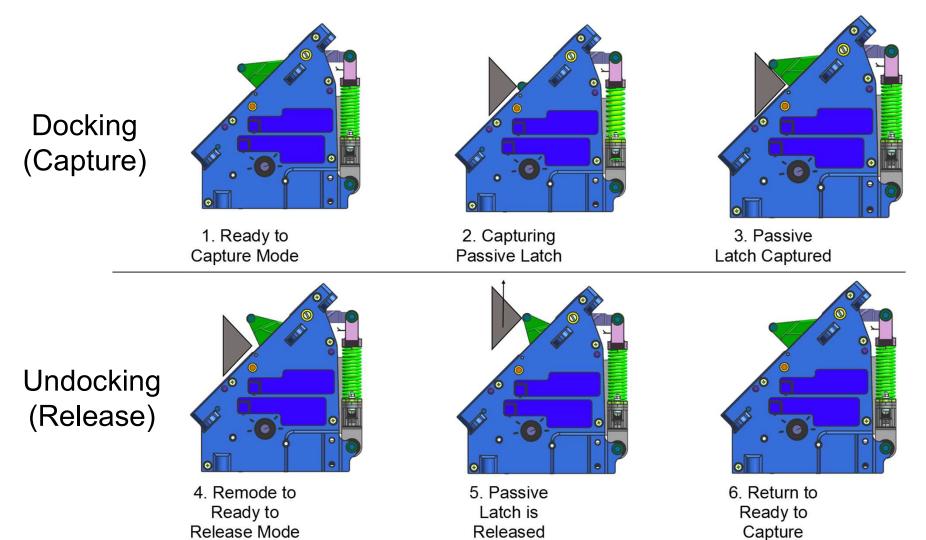


- Latch Pawl: Latching feature that reacts load from Passive Striker to attain capture between mating docking systems.
- Passive latch striker plate: This is a simplified representation of the stationary latch interface hardware on the passive docking system.
- **Motor:** Provides the nominal actuation for the mechanism.
- Internal Transmission/Linkage System: Transmits torque from the motor to the Latch Pawl and retains the pawl in desired position.
- Secondary Release Mechanism: Provides for secondary release in the event of a nominal drive system failure.

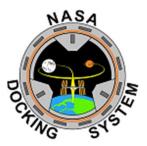


### **Capture Latch Nominal Operations**

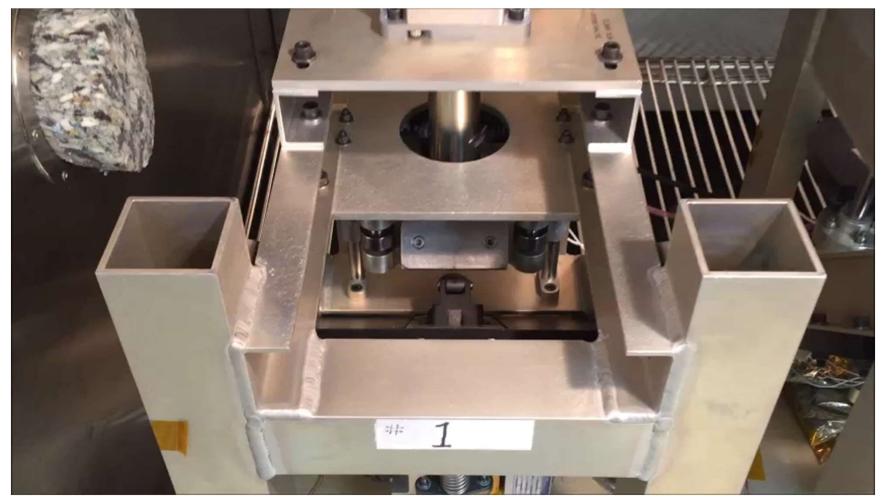




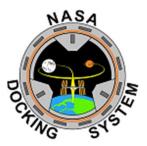
### **Capture Latch Nominal Operations**



#### **Docking Simulation**



### **Capture Latch Nominal Operations**

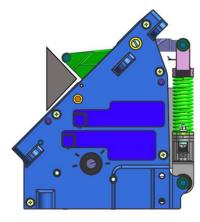


#### **Undocking Simulation**

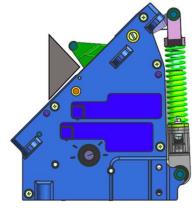


### **Capture Latch Off-Nominal Operations**

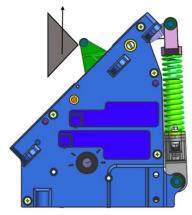
Capture Latch Secondary Release



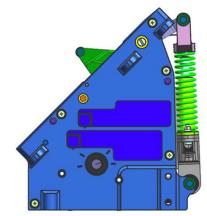
1. Passive Latch Captured



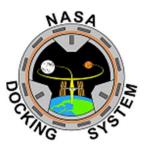
2. Secondary Release (NEA) Activated



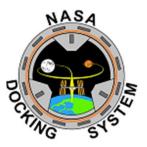
3. Passive Latch is Released



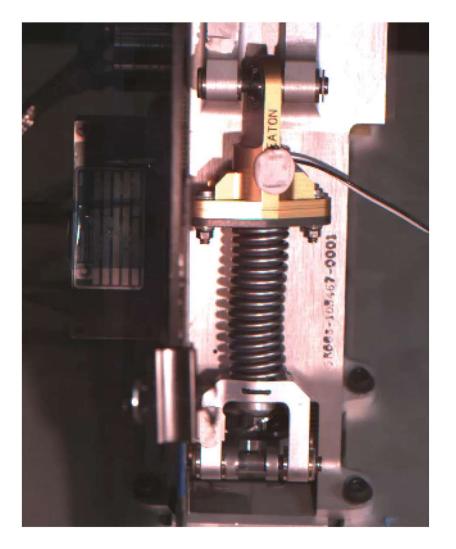
4. CLA is Permanently in Release Mode

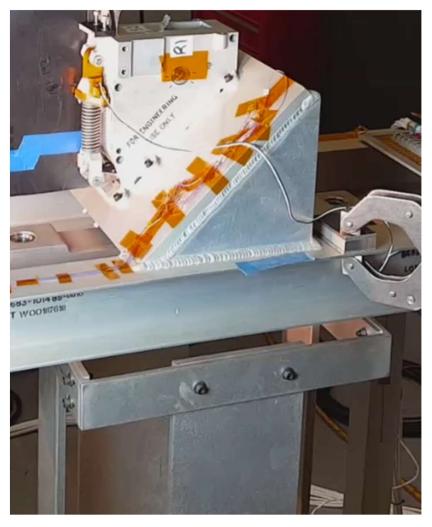


### **Capture Latch Off-Nominal Operations**



#### Capture Latch Secondary Release

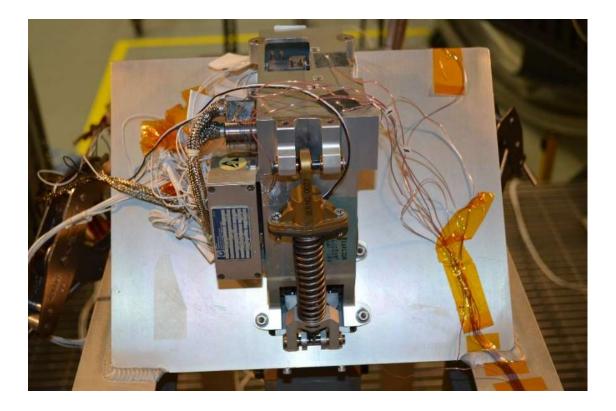




### **Testing Summary**



- Test Campaign:
  - Development
  - Qualification
  - Acceptance
- Tests Included:
  - Run-In
  - Functional
  - Random Vibration
  - Thermal Vacuum & Thermal Cycling
  - Primary Release
  - Secondary
  - Static Load



#### **Motor Failures**

 Description of Failure: During the thermal cycling portion of acceptance testing, some motors failed to operate or exhibited erratic/intermittent behavior.

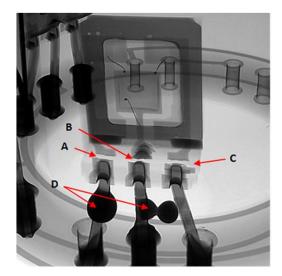
#### Failure Investigation Summary:

- Troubleshooting and teardown was performed on the failed units.
- Ultimately the failure was found to be caused by cracks in the Hall Effect Device (HED) in the motor.
- The cracks were found to be caused by thermally induced stresses in the potting material, exacerbated by voids.

#### Corrective Action

- Potting material was changed to a new material with a more compatible CTE
- Potting process changed to prevent void generation.
- All 12 flight motors successfully testing after redesign without issue.







#### Secondary Release Mechanism Failures

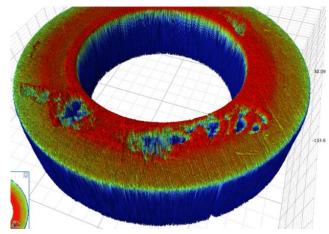


- Description of Failure: During development and qualification testing, the secondary release mechanism failed to deploy.
- Failure Investigation Summary:
  - Teardown and inspection of the mechanism revealed the presence of galling inside the Non-Explosive Actuator (NEA).
  - Testing was performed which demonstrated that the galling was caused by the motion of the mechanism during vibration testing.

#### Corrective Action:

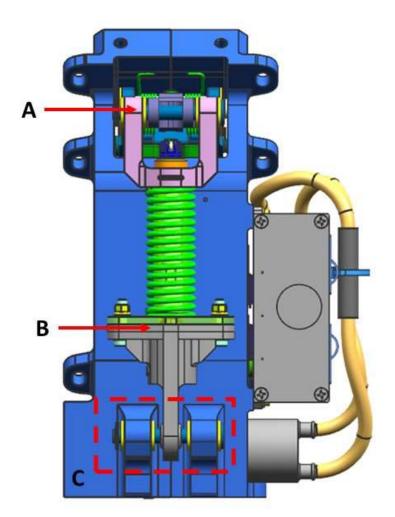
- The mechanism supports were redesigned to eliminate motion during testing.
- After the redesign, the qualification testing was repeated successfully.

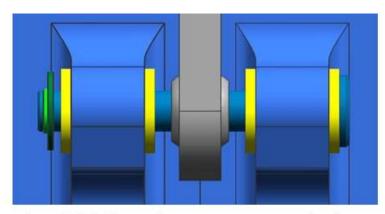




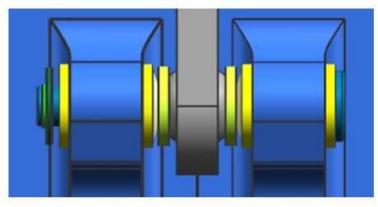
### Secondary Release Mechanism Failures







C – NEA Attachment, pre-redesign



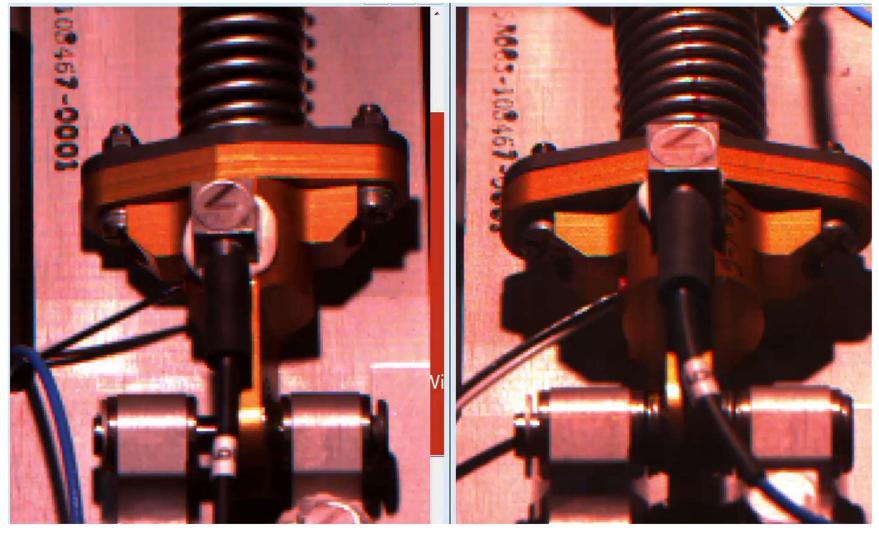
C – NEA Attachment, post-redesign

## Secondary Release Mechanism Failures

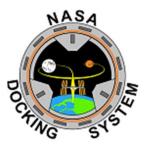


Pre-Redesign

#### Post-Redesign







- Avoid Loosely Constrained Parts
- Pay Attention to Thermal Stresses In Potted Parts
- Fully Address Failures During Development Testing
- Watch the Test Whenever Possible
- Use Caution with Commercial Off The Shelf (COTS) Parts

